



STN2NF10

N-channel 100V - 0.23Ω - 2.4A - SOT-223
STripFET™ II Power MOSFET

Features

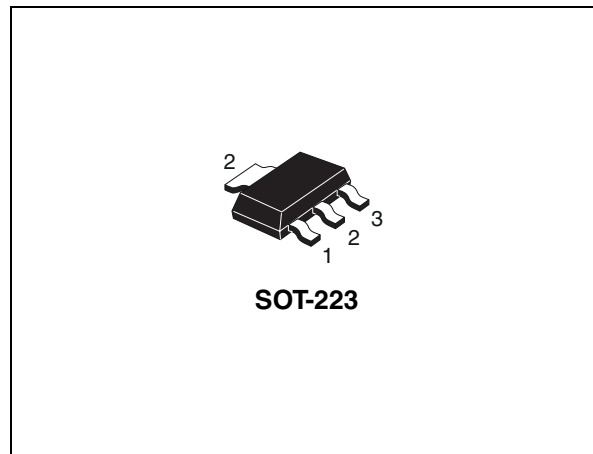
| Type | V _{DSS} | R _{DS(on)} | I _D |
|----------|------------------|---------------------|----------------|
| STN2NF10 | 100V | < 0.26Ω | 2.4A |

Description

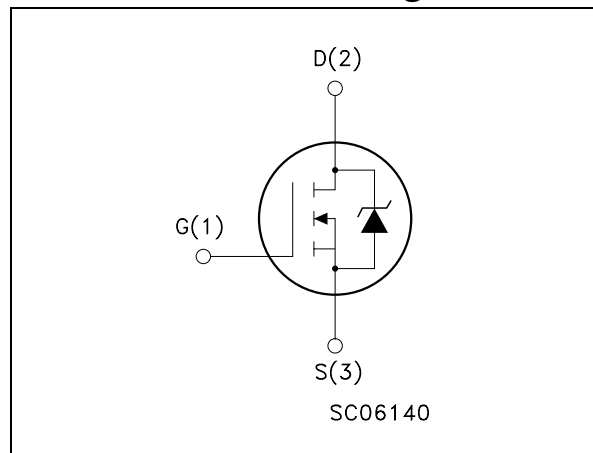
This Power MOSFET is the latest development of STMicroelectronics unique “single feature size” strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

Application

- Switching application
 - DC-DC converters



Internal schematic diagram



Order code

| Part number | Marking | Package | Packaging |
|-------------|---------|---------|-------------|
| STN2NF10 | N2NF10 | SOT-223 | Tape & reel |

Contents

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1 Electrical ratings

Table 1. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|--------------------|---|------------|---------------------|
| V_{DS} | Drain-source voltage ($V_{GS}=0$) | 100 | V |
| V_{GS} | Gate-source voltage | ± 20 | V |
| I_D | Drain current (continuous) at $T_C = 25^\circ\text{C}$ | 2.4 | A |
| I_D | Drain current (continuous) at $T_C = 100^\circ\text{C}$ | 1.5 | A |
| $I_{DM}^{(1)}$ | Drain current (pulsed) | 17 | A |
| | Derating factor | 0.026 | W/ $^\circ\text{C}$ |
| $P_{TOT}^{(2)}$ | Total dissipation at $T_C = 25^\circ\text{C}$ | 3.3 | W |
| $E_{AS}^{(3)}$ | Single pulse avalanche energy | 200 | mJ |
| $dv/dt^{(4)}$ | Peak diode recovery voltage slope | 30 | V/ns |
| T_j T_{stg} | Operating junction temperature Storage temperature | -55 to 150 | $^\circ\text{C}$ |

1. Pulse width limited by safe operating area
2. This value is rated according to $R_{thj-amb}$, $t \leq 10\text{sec}$
3. $I_{AS} = 2.4\text{A}$, $V_{DD} = 30\text{V}$, $R_g = 4.7\Omega$, starting $T_j = 25^\circ\text{C}$
4. $I_{SD} \leq 6\text{A}$, $di/dt \leq 500\text{A}/\mu\text{s}$, $V_{DD} = 80\% V_{(BR)DSS}$

Table 2. Thermal data

| Symbol | Parameter | Value | Unit |
|---------------------|---------------------------------|-------|---------------------------|
| $R_{thj-amb}^{(1)}$ | Thermal resistance junction-amb | 38 | $^\circ\text{C}/\text{W}$ |
| $R_{thj-amb}^{(2)}$ | Thermal resistance junction-amb | 62.5 | $^\circ\text{C}/\text{W}$ |

1. When mounted on 1inch² FR-4 board, 2 oz. Cu, ($t < 10\text{sec}$)
2. When mounted on 1inch² FR-4 board, 2 oz. Cu, ($t > 10\text{sec}$)

2 Electrical characteristics

($T_{CASE}=25^{\circ}C$ unless otherwise specified)

Table 3. On/off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|--|---|------|------|--------------|-------------------------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $I_D = 250\mu A, V_{GS} = 0$ | 100 | | | V |
| I_{DSS} | Zero gate voltage drain current ($V_{GS} = 0$) | $V_{DS} = \text{Max rating},$ $V_{DS} = \text{Max rating}, T_c = 125^{\circ}C$ $V_{DS} = 30V, T_c = 125^{\circ}C$ | | | 1 10 1 | μA μA μA |
| I_{GSS} | Gate body leakage current ($V_{DS} = 0$) | $V_{GS} = \pm 20V$ | | | ± 100 | nA |
| $V_{GS(th)}$ | Gate threshold voltage | $V_{DS} = V_{GS}, I_D = 250\mu A$ | 2 | | 4 | V |
| $R_{DS(on)}$ | Static drain-source on resistance | $V_{GS} = 10V, I_D = 1.2A$ | | 0.23 | 0.26 | Ω |

Table 4. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|------------------------------|--------------------------------------|------|------|------|------|
| g_{fs} | Forward transconductance | $V_{DS} = 15V, I_D = 1.2A$ | | 2.5 | | S |
| C_{iss} | Input capacitance | $V_{DS} = 25V, f = 1MHz, V_{GS} = 0$ | | 280 | | pF |
| C_{oss} | Output capacitance | | | 45 | | pF |
| C_{rss} | Reverse transfer capacitance | | | 20 | | pF |
| Q_g | Total gate charge | $V_{DD} = 80V, I_D = 6A$ | | 10 | 14 | nC |
| Q_{gs} | Gate-source charge | $V_{GS} = 10V$ | | 2.5 | | nC |
| Q_{gd} | Gate-drain charge | (see Figure 15) | | 4 | | nC |

Table 5. Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------------|----------------------------------|--|------|---------|------|----------|
| $t_{d(on)}$ t_r | Turn-on delay time Rise time | $V_{DD}=50V$, $I_D = 2.4A$ $V_{GS} = 10V$, $R_G=4.7\Omega$ (see Figure 14) | | 6 10 | | ns ns |
| $t_{d(off)}$ t_f | Turn-off delay time Fall time | $V_{DD}=50V$, $I_D = 2.4A$ $V_{GS} = 10V$, $R_G=4.7\Omega$ (see Figure 14) | | 20 3 | | ns ns |

Table 6. Source drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max | Unit |
|-----------------------------------|--|--|------|----------------|-----------|---------------|
| I_{SD} $I_{SDM}^{(1)}$ | Source-drain current Source-drain current (pulsed) | | | | 2.4 17 | A A |
| $V_{SD}^{(2)}$ | Forward on voltage | $I_{SD}= 2.4A$, $V_{GS}=0$ | | | 1.2 | V |
| t_{rr} Q_{rr} I_{RRM} | Reverse recovery time Reverse recovery charge Reverse recovery current | $I_{SD}= 6A$, $V_{DD}=10V$ $di/dt=100A/\mu s$, $T_j=150^\circ C$ (see Figure 19) | | 70 175 5 | | ns nC A |

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration = 300 μs , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

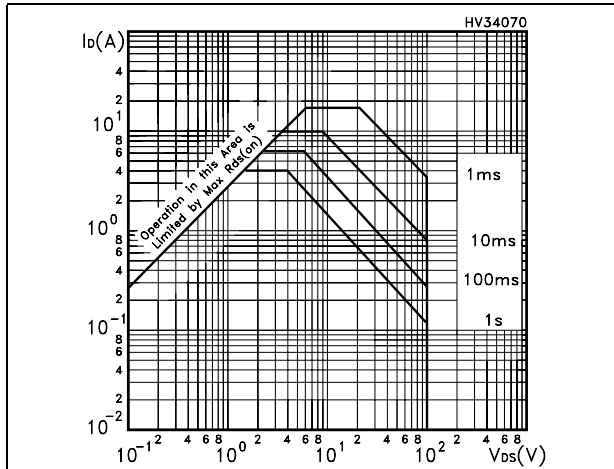


Figure 2. Thermal impedance

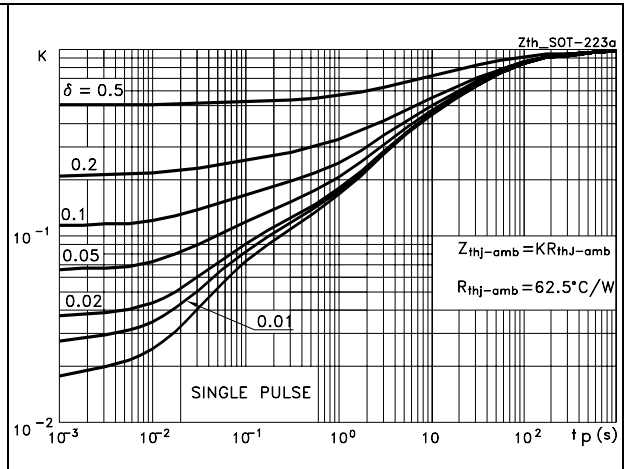


Figure 3. Output characteristics

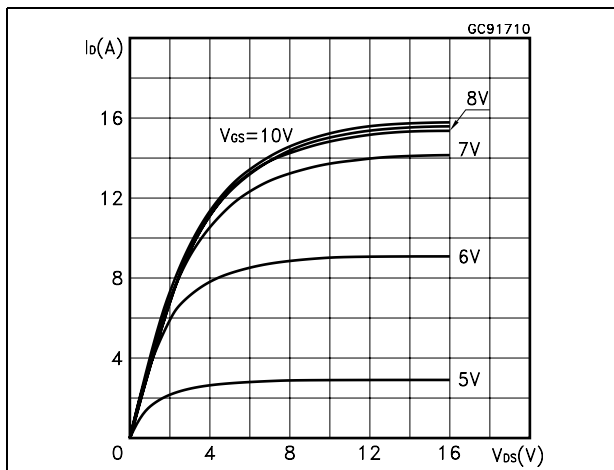


Figure 4. Transfer characteristics

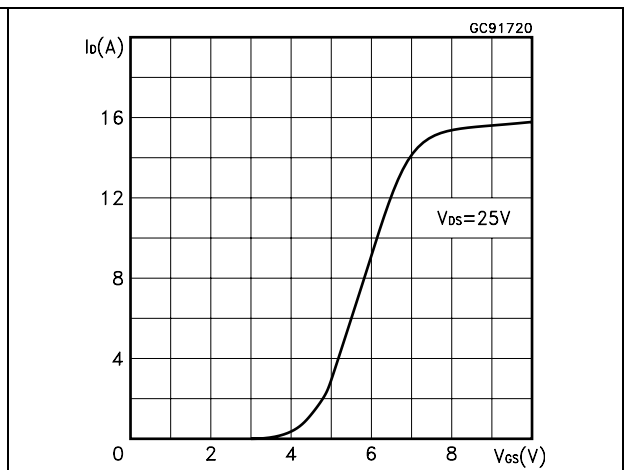


Figure 5. Transconductance

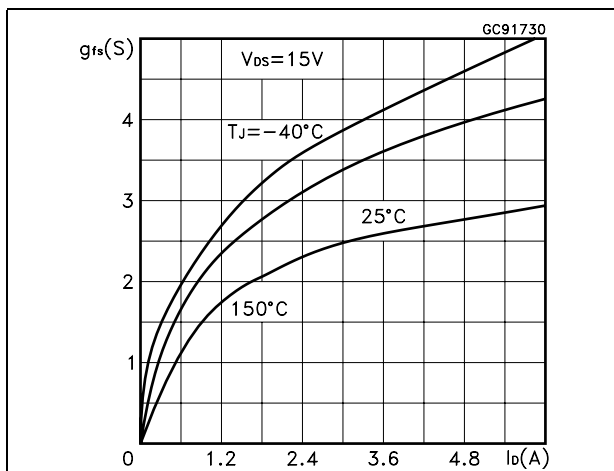


Figure 6. Static drain-source on resistance

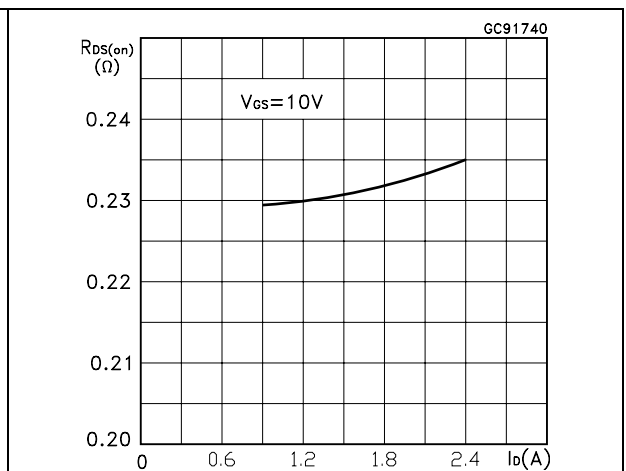


Figure 7. Gate charge vs. gate-source voltage

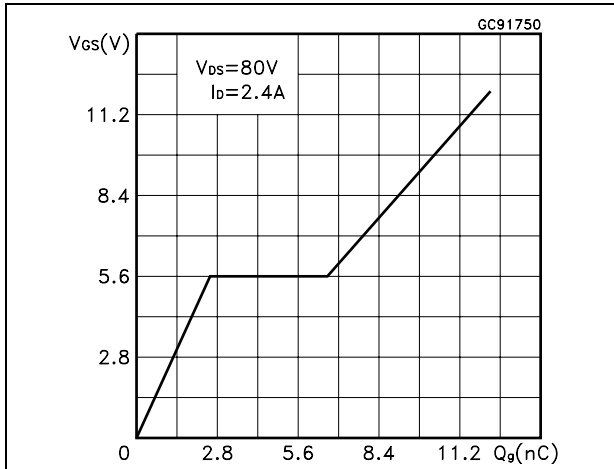


Figure 8. Capacitance variations

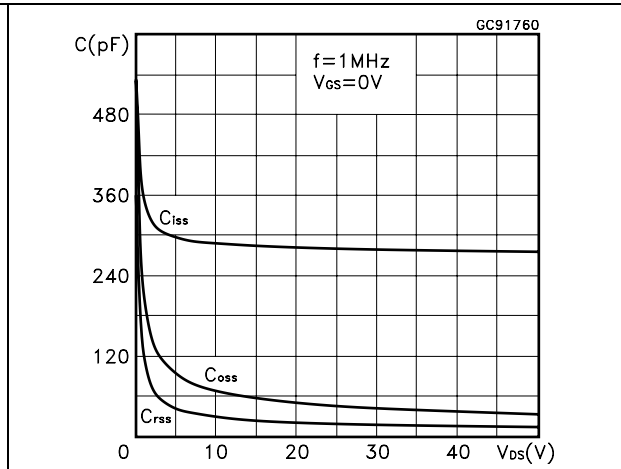


Figure 9. Normalized gate threshold voltage vs. temperature

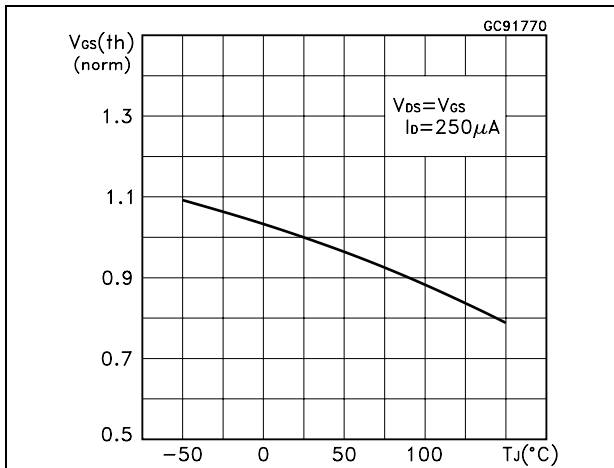


Figure 10. Normalized on resistance vs. temperature

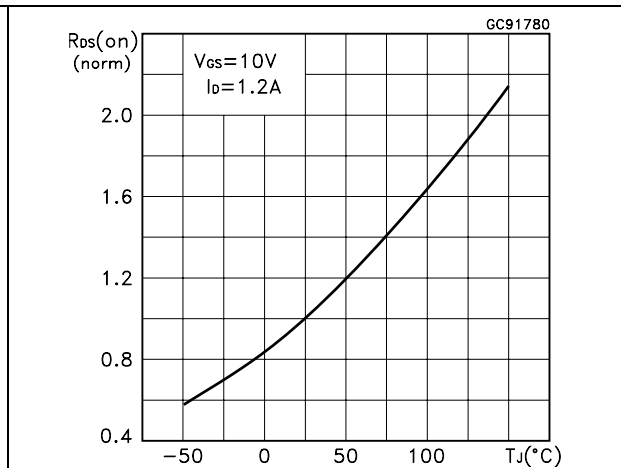


Figure 11. Source-drain diode forward characteristics

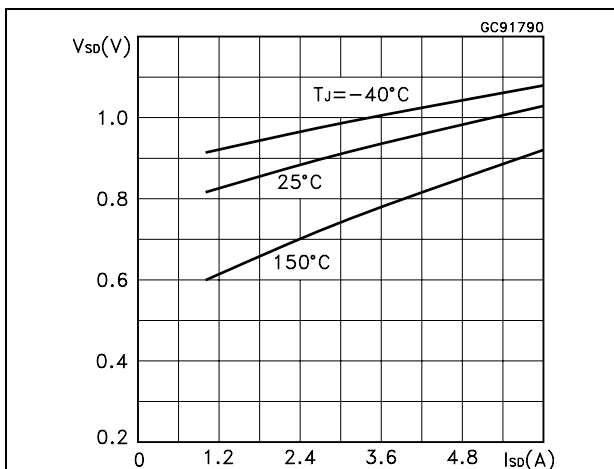


Figure 12. Normalized BV_{DSS} vs. temperature

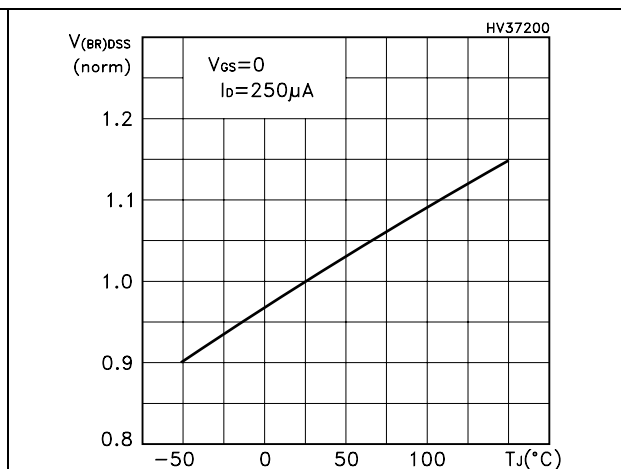
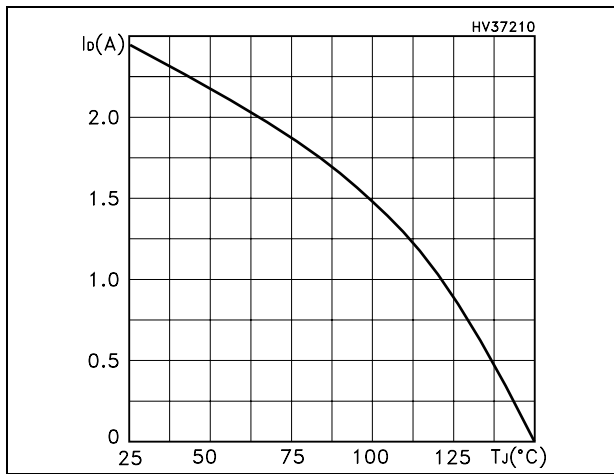


Figure 13. Max drain current vs. temperature



3 Test circuit

Figure 14. Switching times test circuit for resistive load

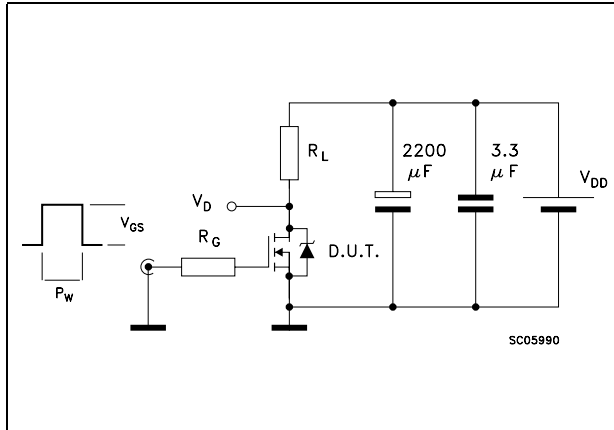


Figure 15. Gate charge test circuit

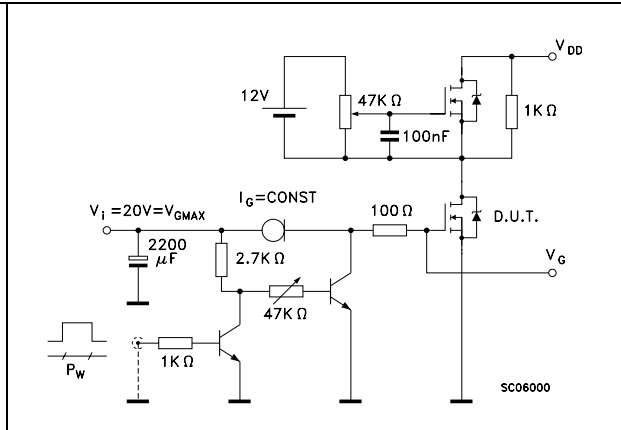


Figure 16. Test circuit for inductive load switching and diode recovery times

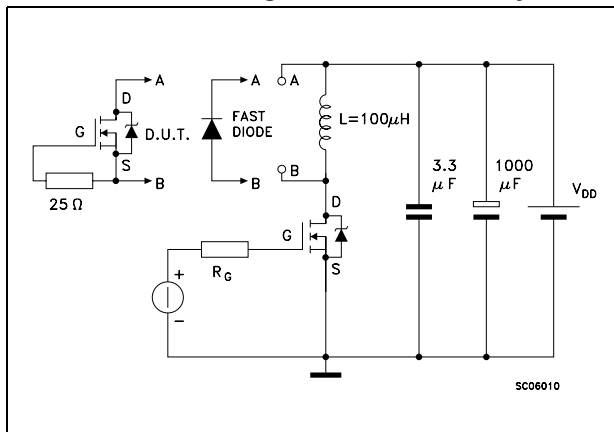


Figure 17. Unclamped inductive load test circuit

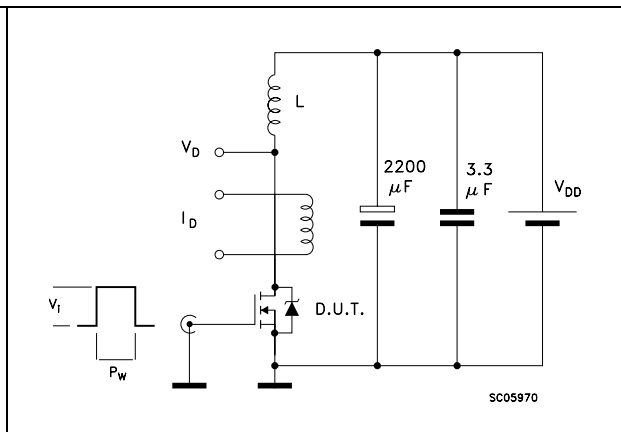


Figure 18. Unclamped inductive waveform

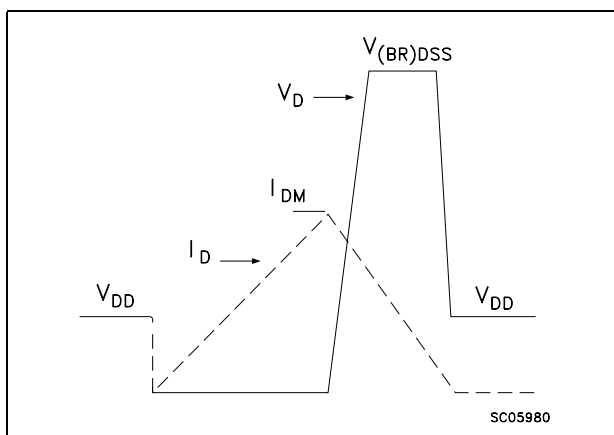
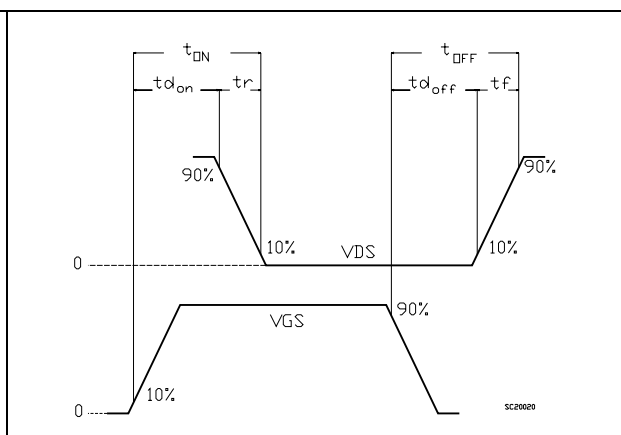


Figure 19. Switching time waveform

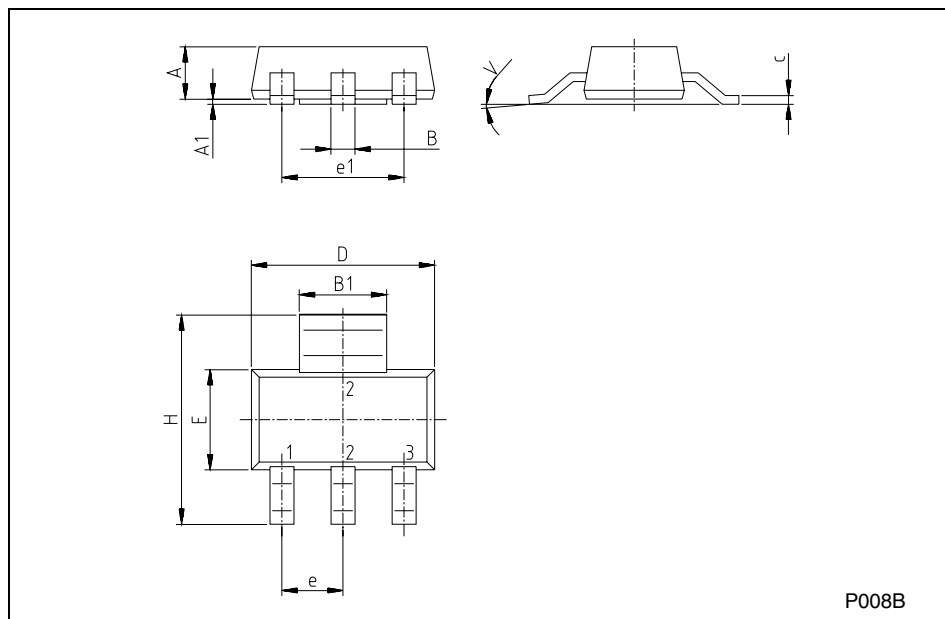


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

SOT-223 MECHANICAL DATA

| DIM. | mm | | | inch | | |
|------|------|------|------|-------|-------|-------|
| | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| A | | | 1.80 | | | 0.071 |
| B | 0.60 | 0.70 | 0.80 | 0.024 | 0.027 | 0.031 |
| B1 | 2.90 | 3.00 | 3.10 | 0.114 | 0.118 | 0.122 |
| c | 0.24 | 0.26 | 0.32 | 0.009 | 0.010 | 0.013 |
| D | 6.30 | 6.50 | 6.70 | 0.248 | 0.256 | 0.264 |
| e | | 2.30 | | | 0.090 | |
| e1 | | 4.60 | | | 0.181 | |
| E | 3.30 | 3.50 | 3.70 | 0.130 | 0.138 | 0.146 |
| H | 6.70 | 7.00 | 7.30 | 0.264 | 0.276 | 0.287 |
| V | | | 10° | | | 10° |
| A1 | | 0.02 | | | | |



5 Revision history

Table 7. Revision history

| Date | Revision | Changes |
|-------------|----------|--|
| 14-Sep-2006 | 4 | The document has been reformatted |
| 29-Mar-2007 | 5 | <i>Figure 1</i> has been updated |
| 04-Apr-2007 | 6 | New test condition for I_{DSS} on <i>Table 3</i> |

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